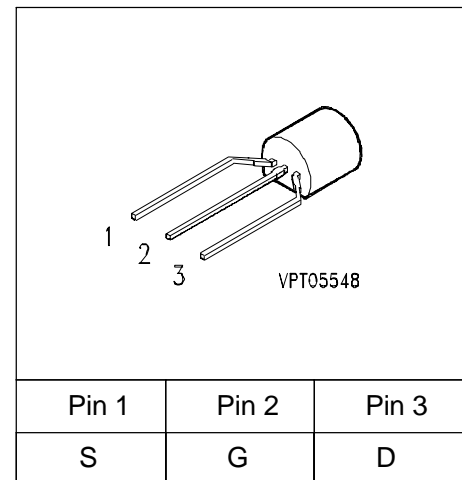


## BSS 98

### SIPMOS® Small-Signal Transistor

- N channel
- Enhancement mode
- Logic Level
- $V_{GS(th)} = 0.8...1.6 V$



| Type   | $V_{DS}$ | $I_D$ | $R_{DS(on)}$ | Package | Marking |
|--------|----------|-------|--------------|---------|---------|
| BSS 98 | 50 V     | 0.3 A | 3.5 $\Omega$ | TO-92   | SS98    |

| Type   | Ordering Code | Tape and Reel Information |
|--------|---------------|---------------------------|
| BSS 98 | Q62702-S053   | E6288                     |
| BSS 98 | Q62702-S517   | E6296                     |
| BSS 98 | Q62702-S635   | E6325                     |

### Maximum Ratings

| Parameter                          | Symbol      | Values   | Unit |
|------------------------------------|-------------|----------|------|
| Drain source voltage               | $V_{DS}$    | 50       | V    |
| Drain-gate voltage                 | $V_{DGR}$   | 50       |      |
| $R_{GS} = 20 k\Omega$              |             |          |      |
| Gate source voltage                | $V_{GS}$    | $\pm 20$ |      |
| ESD Sensitivity as per MIL-STD 883 |             | Class 1  |      |
| Continuous drain current           | $I_D$       | 0.3      | A    |
| $T_A = 25\text{ }^\circ\text{C}$   |             |          |      |
| DC drain current, pulsed           | $I_{Dpuls}$ | 1.2      |      |
| $T_A = 25\text{ }^\circ\text{C}$   |             |          |      |
| Power dissipation                  | $P_{tot}$   | 0.63     | W    |
| $T_A = 25\text{ }^\circ\text{C}$   |             |          |      |

**Maximum Ratings**

| Parameter   | Symbol     | Values        | Unit |
|---|------------|---------------|------|
| Chip or operating temperature                         | $T_j$      | -55 ... + 150 | °C   |
| Storage temperature                                   | $T_{stg}$  | -55 ... + 150 |      |
| Thermal resistance, chip to ambient air <sup>1)</sup> | $R_{thJA}$ | ≤ 200         | K/W  |
| DIN humidity category, DIN 40 040                     |            | E             |      |
| IEC climatic category, DIN IEC 68-1                   |            | 55 / 150 / 56 |      |

**Electrical Characteristics, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified**

| Parameter | Symbol | Values |      |      | Unit |
|-----------|--------|--------|------|------|------|
|           |        | min.   | typ. | max. |      |

**Static Characteristics**

|  |               |     |      |     |    |
|--|---------------|-----|------|-----|----|
| Drain- source breakdown voltage<br>$V_{GS} = 0\text{ V}$ , $I_D = 0.25\text{ mA}$ , $T_j = 25^\circ\text{C}$ | $V_{(BR)DSS}$ | 50  | -    | -   | V  |
| Gate threshold voltage<br>$V_{GS} = V_{DS}$ , $I_D = 1\text{ mA}$  | $V_{GS(th)}$  | 0.8 | 1.2  | 1.6 |    |
| Zero gate voltage drain current<br>$V_{DS} = 50\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 25^\circ\text{C}$ | $I_{DSS}$     | -   | 0.05 | 0.5 | μA |
| $V_{DS} = 50\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 125^\circ\text{C}$                                   |               | -   | -    | 5   |    |
| $V_{DS} = 30\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 25^\circ\text{C}$                                    |               | -   | -    | 100 | nA |
| Gate-source leakage current<br>$V_{GS} = 20\text{ V}$ , $V_{DS} = 0\text{ V}$                                | $I_{GSS}$     | -   | 10   | 100 | nA |
| Drain-Source on-state resistance<br>$V_{GS} = 10\text{ V}$ , $I_D = 0.3\text{ A}$                            | $R_{DS(on)}$  | -   | 1.8  | 3.5 | Ω  |
| $V_{GS} = 4.5\text{ V}$ , $I_D = 0.3\text{ A}$   |               | -   | 2.8  | 6   |    |

**Electrical Characteristics, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified**

| Parameter | Symbol | Values |      |      | Unit |
|-----------|--------|--------|------|------|------|
|           |        | min.   | typ. | max. |      |

**Dynamic Characteristics**

|  |              |      |      |    |    |
|--|--------------|------|------|----|----|
| Transconductance<br>$V_{DS} \geq 2 * I_D * R_{DS(on)max}, I_D = 0.3 \text{ A}$                                   | $g_{fs}$     | 0.12 | 0.23 | -  | S  |
| Input capacitance<br>$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$                            | $C_{iss}$    | -    | 40   | 55 | pF |
| Output capacitance<br>$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$                           | $C_{oss}$    | -    | 15   | 25 |    |
| Reverse transfer capacitance<br>$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$                 | $C_{rss}$    | -    | 5    | 8  |    |
| Turn-on delay time<br>$V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 0.29 \text{ A}$<br>$R_G = 50 \Omega$  | $t_{d(on)}$  | -    | 5    | 8  | ns |
| Rise time<br>$V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 0.29 \text{ A}$<br>$R_G = 50 \Omega$           | $t_r$        | -    | 6    | 9  |    |
| Turn-off delay time<br>$V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 0.29 \text{ A}$<br>$R_G = 50 \Omega$ | $t_{d(off)}$ | -    | 12   | 16 |    |
| Fall time<br>$V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 0.29 \text{ A}$<br>$R_G = 50 \Omega$           | $t_f$        | -    | 15   | 20 |    |

**Electrical Characteristics, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified**

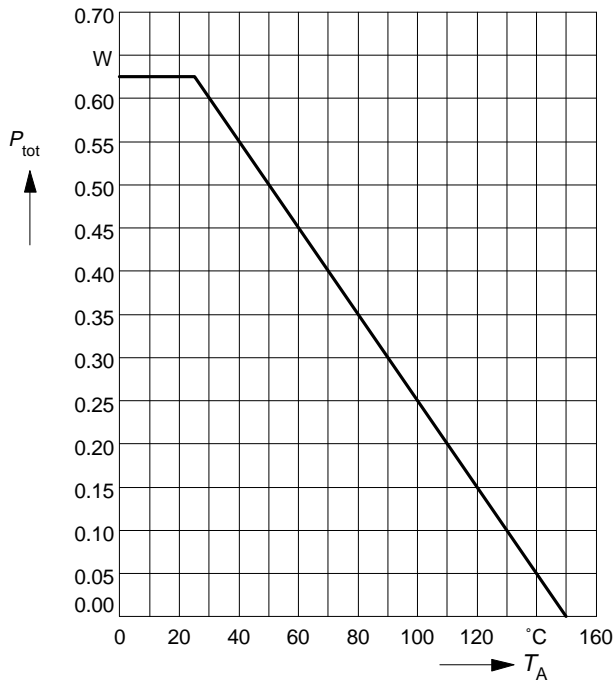
| Parameter | Symbol | Values |      |      | Unit |
|-----------|--------|--------|------|------|------|
|           |        | min.   | typ. | max. |      |

**Reverse Diode**

|  |          |   |   |     |   |
|--|----------|---|---|-----|---|
| Inverse diode continuous forward current<br>$T_A = 25^\circ\text{C}$       | $I_S$    | - | - | 0.3 | A |
| Inverse diode direct current, pulsed<br>$T_A = 25^\circ\text{C}$           | $I_{SM}$ | - | - | 1.2 |   |
| Inverse diode forward voltage<br>$V_{GS} = 0\text{ V}, I_F = 0.6\text{ A}$ | $V_{SD}$ | - | 1 | 1.4 | V |

**Power dissipation**

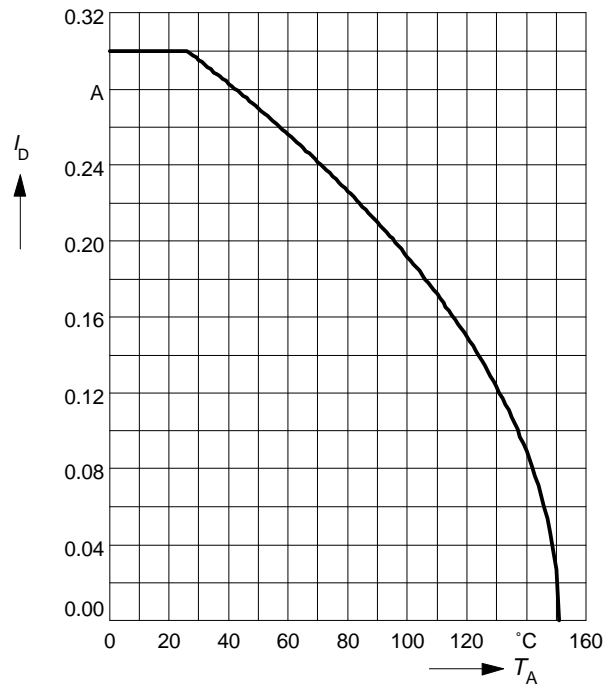
$P_{tot} = f(T_A)$



**Drain current**

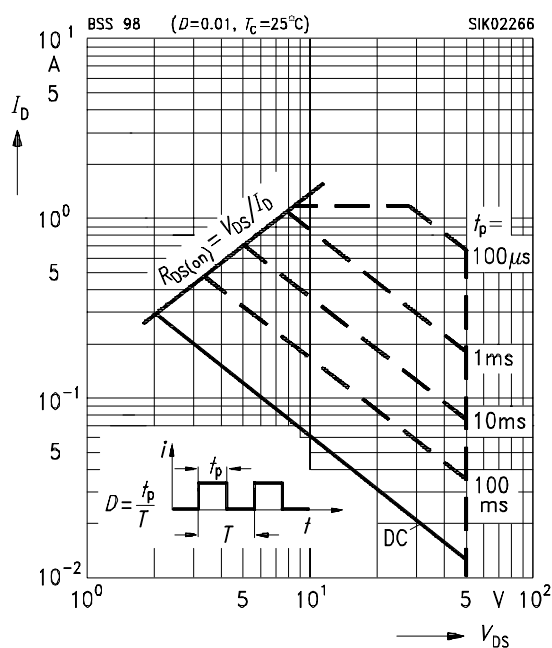
$I_D = f(T_A)$

parameter:  $V_{GS} \geq 10$  V



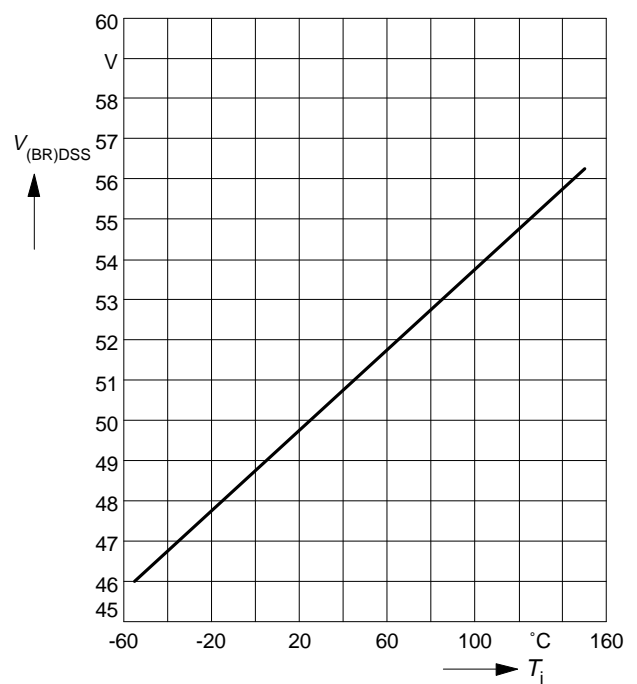
**Safe operating area  $I_D = f(V_{DS})$**

parameter :  $D = 0.01$ ,  $T_C = 25^\circ\text{C}$



**Drain-source breakdown voltage**

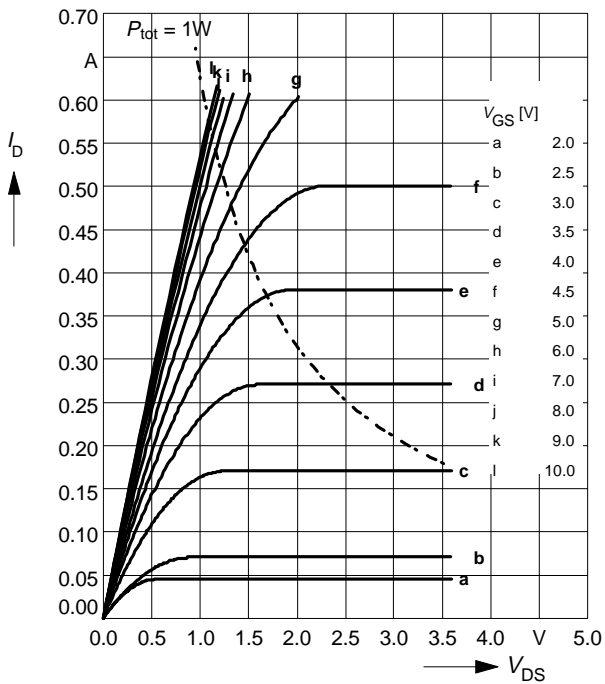
$V_{(BR)DSS} = f(T_j)$



**Typ. output characteristics**

$I_D = f(V_{DS})$

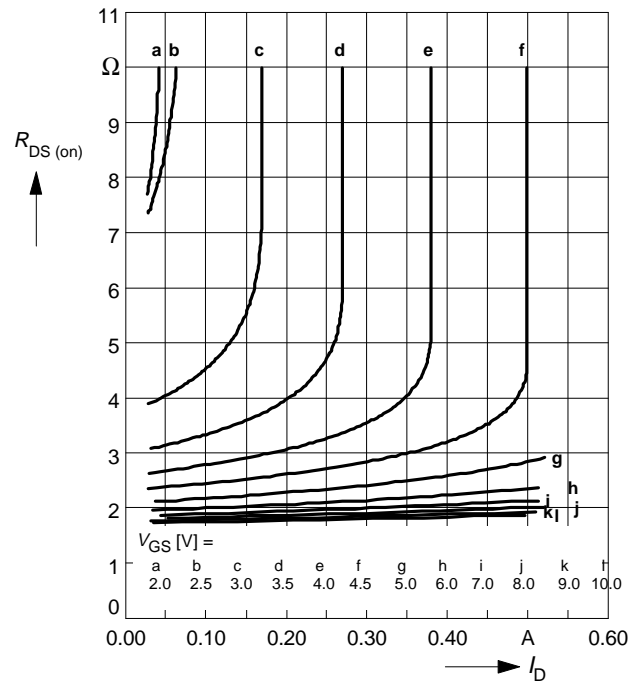
parameter:  $t_p = 80 \mu s$ ,  $T_j = 25^\circ C$



**Typ. drain-source on-resistance**

$R_{DS(on)} = f(I_D)$

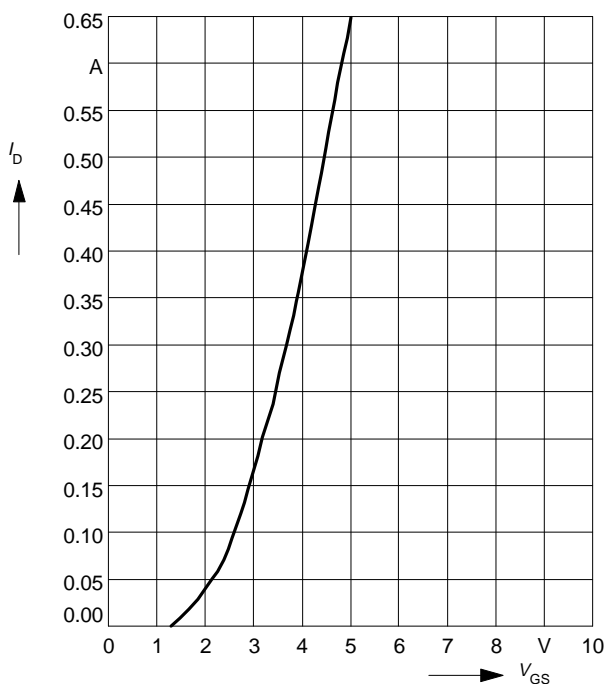
parameter:  $t_p = 80 \mu s$ ,  $T_j = 25^\circ C$



**Typ. transfer characteristics  $I_D = f(V_{GS})$**

parameter:  $t_p = 80 \mu s$

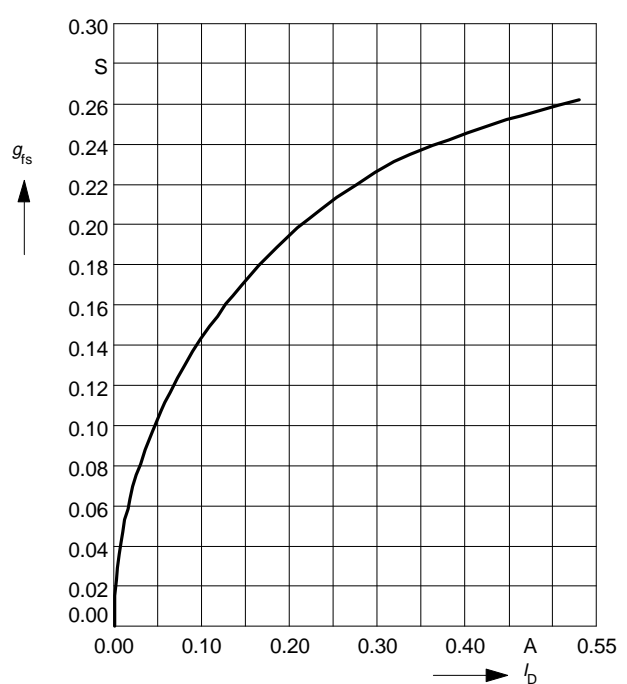
$V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$



**Typ. forward transconductance  $g_{fs} = f(I_D)$**

parameter:  $t_p = 80 \mu s$ ,

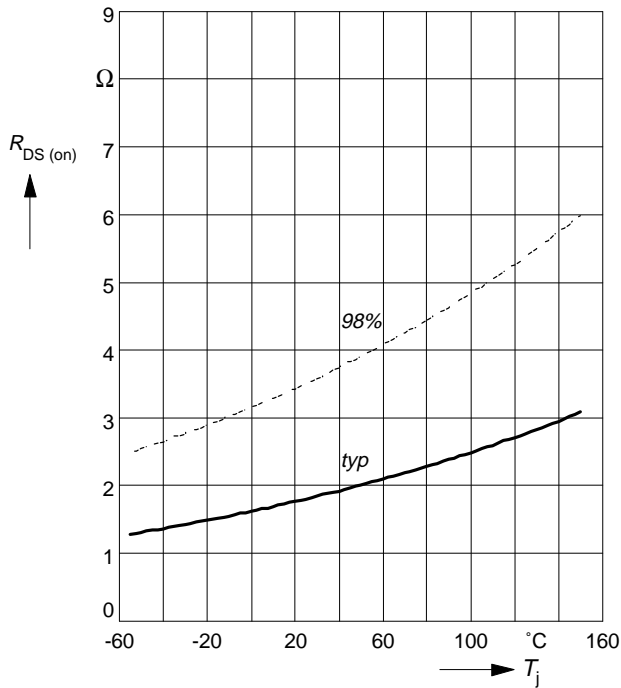
$V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$



**Drain-source on-resistance**

$$R_{DS(on)} = f(T_j)$$

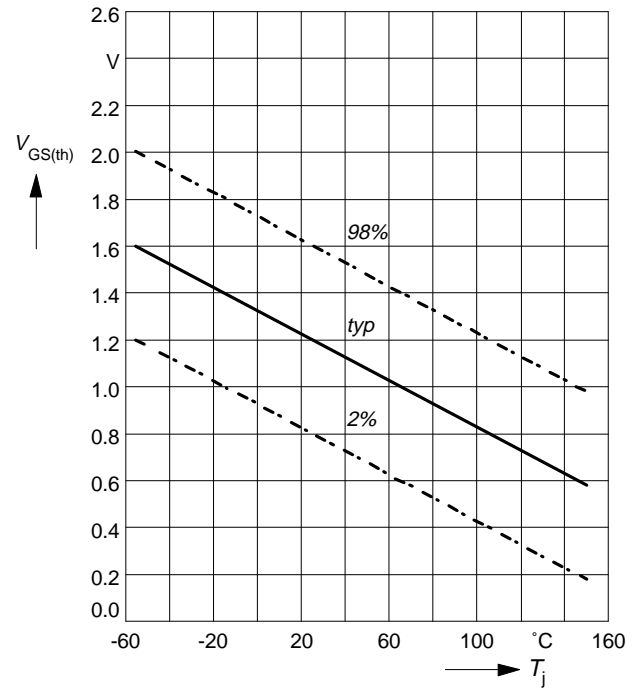
parameter:  $I_D = 0.3 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$



**Gate threshold voltage**

$$V_{GS(th)} = f(T_j)$$

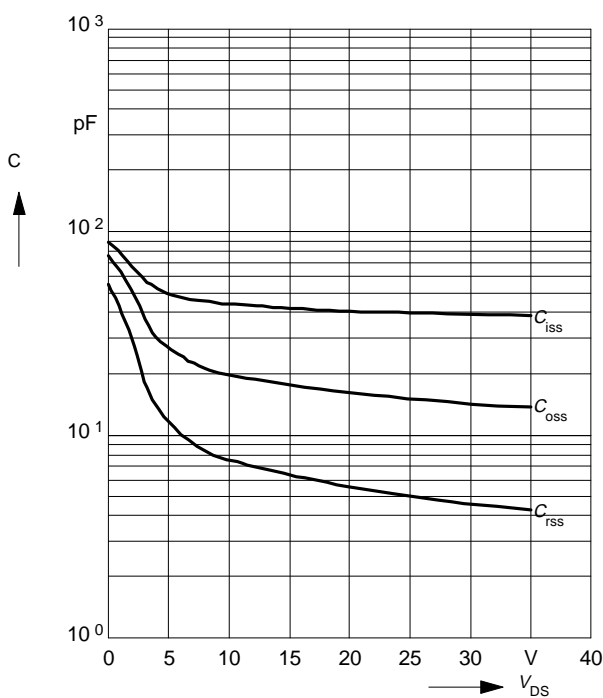
parameter:  $V_{GS} = V_{DS}$ ,  $I_D = 1 \text{ mA}$



**Typ. capacitances**

$$C = f(V_{DS})$$

parameter:  $V_{GS} = 0 \text{ V}$ ,  $f = 1 \text{ MHz}$



**Forward characteristics of reverse diode**

$$I_F = f(V_{SD})$$

parameter:  $T_j, t_p = 80 \mu\text{s}$

